







CSD13381F4 SLPS448F - JULY 2013 - REVISED JANUARY 2022

CSD13381F4 12-V N-Channel FemtoFET MOSFET

1 Features

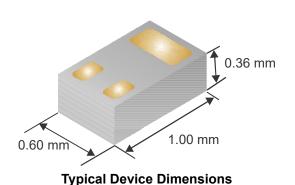
- Low on-resistance
- Low Q_a and Q_{ad}
- Low threshold voltage
- Ultra-small footprint (0402 case size)
 - 1.0 mm × 0.6 mm
- Ultra-low profile
 - Maximum height: 0.36-mm
- Integrated ESD protection diode
 - Rated > 4-kV HBM
 - Rated > 2-kV CDM
- Lead and halogen free
- RoHS compliant

2 Applications

- Optimized for load switch applications
- Optimized for general purpose switching applications
- Single-cell battery applications
- Handheld and mobile applications

3 Description

This 140-mΩ, 12-V N-channel FemtoFET™ MOSFET technology is designed and optimized to minimize the footprint in many handheld and mobile applications. This technology is capable of replacing standard small signal MOSFETs while providing at least a 60% reduction in footprint size.



Product Summary

T _A = 25°	C	TYPICAL VA	UNIT				
V _{DS}	Drain-to-source voltage	12	12			12	
Qg	Gate charge total (4.5 V)	1060		рC			
Q _{gd}	Gate charge gate-to-drain	140	рC				
		V _{GS} = 1.8 V	310	mΩ			
R _{DS(on)}	Drain-to-source on-resistance	V _{GS} = 2.5 V	170	mΩ			
		V _{GS} = 4.5 V	140	mΩ			
V _{GS(th)}	Threshold voltage	0.85		V			

Ordering Information

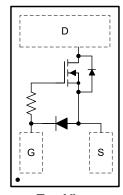
DEVICE ⁽¹⁾	QTY	MEDIA	PACKGE	SHIP
CSD13381F4	3000	7-inch	Femto (0402) 1.0-mm ×	Tape and
CSD13381F4T	250	reel	0.6-mm SMD lead less	reel

For all available packages, see the orderable addendum at the end of the data sheet.

Absolute Maximum Ratings

T _A = 25	°C unless otherwise stated	VALUE	UNIT	
V _{DS}	Drain-to-source voltage	12	V	
V _{GS}	Gate-to-source voltage	8	V	
I _D	Continuous drain current, T _A = 25°C ⁽¹⁾	2.1	Α	
I _{DM}	Pulsed drain current, T _A = 25°C ⁽²⁾	7	Α	
1.	Continuous gate clamp current	35	mA	
IG	Pulsed gate clamp current ⁽²⁾	350		
P _D	Power dissipation ⁽¹⁾	500	mW	
ESD	Human body model (HBM)	4	kV	
Rating	Charged device model (CDM)	2	kV	
T _J , T _{stg}	Operating junction and storage temperature range	-55 to 150	°C	
E _{AS}	Avalanche energy, single pulse I _D = 7.4 A, L = 0.1 mH, R_G = 25 Ω	2.7	mJ	

- Typical $R_{\theta,JA} = 90^{\circ}C/W$ on 1 inch² (6.45 cm²), 2 oz. (0.071 mm thick) Cu pad on a 0.06 inch (1.52 mm) thick FR4 PCB.
- Pulse duration ≤ 300 µs, duty cycle ≤ 2%



Top View



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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

•	•	•	. 0		
Changes fron	n Revision E (Octob	er 2021) to Revisio	n F (January 2022))	Page
 Changed M 	laximum height from	"0.35 mm" to "0.36 r	mm" in <i>Features</i>		1
 Changed pages 	ackage height from "	0.35 mm" to "0.36 m	m" in <i>Typical Devic</i> e	e Dimensions	1
Changed p	ackage height from "	0.35 mm" to "0.36 m	m" in <i>Mechanical D</i>	Dimensions	8
Changes from	n Revision D (May 2	2015) to Revision E	(October 2021)		Page
Added footi	note with link to supp	ort document			9
Changes from	n Revision C (Septe	mber 2014) to Revi	sion D (May 2015)		Page
Corrected t	ypo for I _{GSS} Test Cor	ndition			3

5 Specifications

5.1 Electrical Characteristics

(T_A = 25°C unless otherwise stated)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC	CHARACTERISTICS					
BV _{DSS}	Drain-to-Source Voltage	V _{GS} = 0 V, I _{DS} = 250 μA	12			V
I _{DSS}	Drain-to-Source Leakage Current	V _{GS} = 0 V, V _{DS} = 9.6 V			100	nA
I _{GSS}	Gate-to-Source Leakage Current	V _{DS} = 0 V, V _{GS} = 8 V			50	nA
V _{GS(th)}	Gate-to-Source Threshold Voltage	$V_{DS} = V_{GS}$, $I_{DS} = 250 \mu A$	0.65	0.85	1.10	V
		V _{GS} = 1.8 V, I _{DS} = 0.5 A		310	400	mΩ
R _{DS(on)}	Drain-to-Source On-Resistance	V _{GS} = 2.5 V, I _{DS} = 0.5 A		170	225	mΩ
	Cir resistants	V _{GS} = 4.5 V, I _{DS} = 0.5 A		140	180	mΩ
g _{fs}	Transconductance	V _{DS} = 6 V, I _{DS} = 0.5 A		3.2		S
DYNAM	IC CHARACTERISTICS					
C _{iss}	Input Capacitance			155	200	pF
C _{oss}	Output Capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 6 \text{ V},$ $f = 1 \text{ MHz}$		47	62	pF
C _{rss}	Reverse Transfer Capacitance	J 1 WH 12		2.5	3.3	pF
R_G	Series Gate Resistance			23		Ω
Qg	Gate Charge Total (4.5 V)			1060	1400	рС
Q _{gd}	Gate Charge Gate-to-Drain	V = C.V.I. = 0.5.A		140		рС
Q _{gs}	Gate Charge Gate-to-Source	V _{DS} = 6 V, I _{DS} = 0.5 A		230		рС
Q _{g(th)}	Gate Charge at V _{th}			155		рС
Q _{oss}	Output Charge	V _{DS} = 6 V, V _{GS} = 0 V		1120		рС
t _{d(on)}	Turn On Delay Time			3.7		ns
t _r	Rise Time	V _{DS} = 6 V, V _{GS} = 4.5 V,		1.5		ns
t _{d(off)}	Turn Off Delay Time	$I_{DS} = 0.5 \text{ A}, R_G = 2 \Omega$		11.0		ns
t_f	Fall Time			3.8		ns
DIODE (CHARACTERISTICS	,				
V _{SD}	Diode Forward Voltage	I _{SD} = 0.5 A, V _{GS} = 0 V		0.73	0.9	V
Q _{rr}	Reverse Recovery Charge	V = 6 V I = 0 E A di/dt = 200 A !:-		1550		рС
t _{rr}	Reverse Recovery Time	V_{DS} = 6 V, I _F = 0.5 A, di/dt = 300 A/ μ s		6		ns

5.2 Thermal Information

(T_A = 25°C unless otherwise stated)

	THERMAL METRIC	TYPICAL VALUES	UNIT
D	Junction-to-Ambient Thermal Resistance ⁽¹⁾	90	°C/W
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance ⁽²⁾	250	C/VV

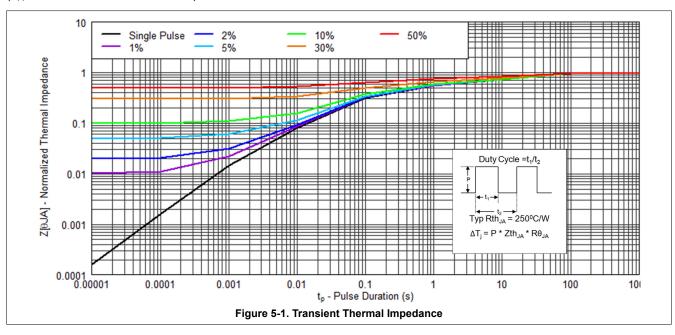
⁽¹⁾ Device mounted on FR4 material with 1 inch² (6.45 cm²), 2 oz. (0.071 mm thick) Cu.

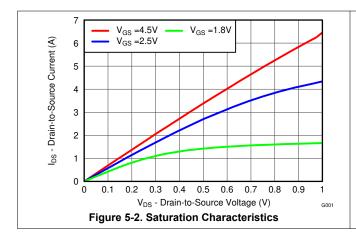
⁽²⁾ Device mounted on FR4 material with minimum Cu mounting area.

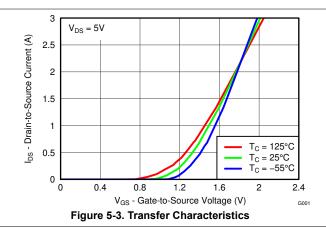


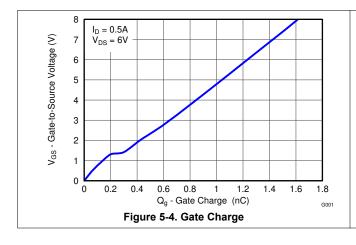
5.3 Typical MOSFET Characteristics

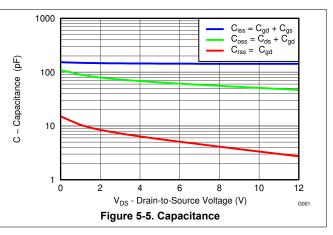
(T_A = 25°C unless otherwise stated)











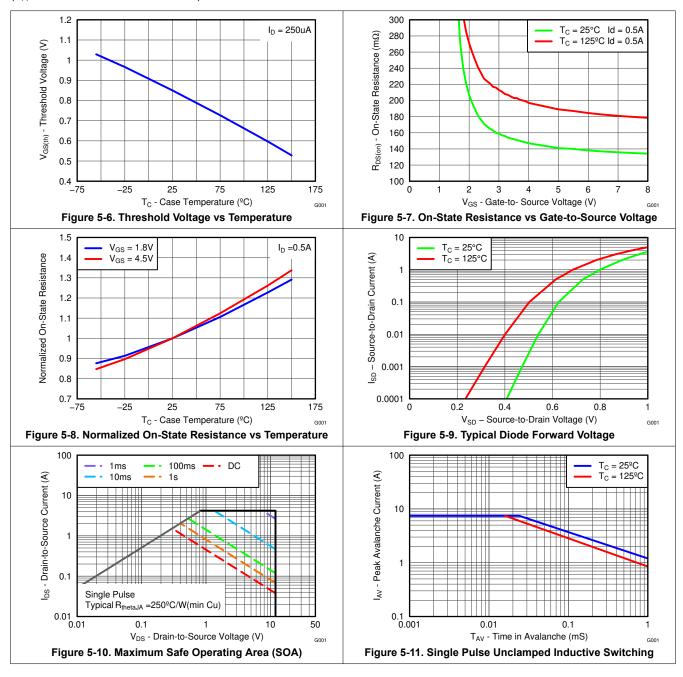
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5.3 Typical MOSFET Characteristics (continued)

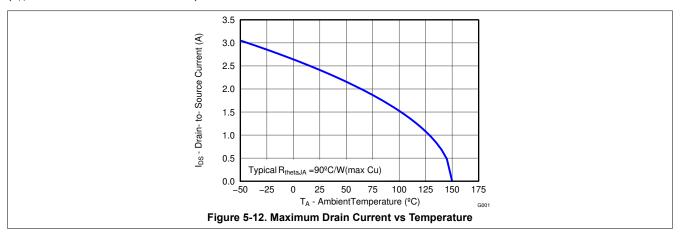
(T_A = 25°C unless otherwise stated)





5.3 Typical MOSFET Characteristics (continued)

(T_A = 25°C unless otherwise stated)





6 Device and Documentation Support

6.1 Trademarks

FemtoFET[™] is a trademark of Texas Instruments. is a trademark of Texas Instruments. All trademarks are the property of their respective owners.

6.2 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

6.3 Glossary

TI Glossary

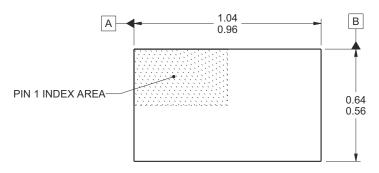
This glossary lists and explains terms, acronyms, and definitions.



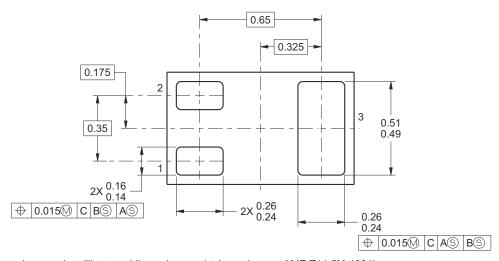
7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

7.1 Mechanical Dimensions



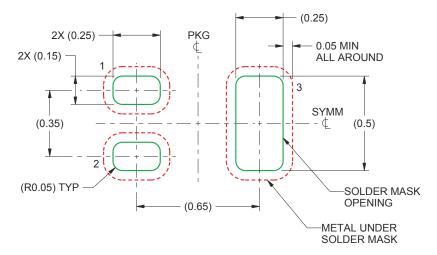




- A. All linear dimensions are in millimeters (dimensions and tolerancing per AME T14.5M-1994).
- B. This drawing is subject to change without notice.
- C. This package is a PB-free solder land design.

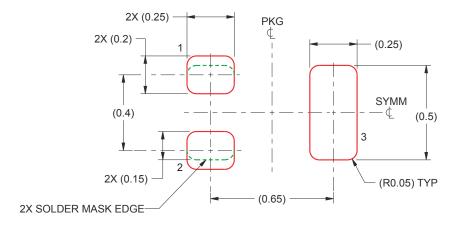


7.2 Recommended Minimum PCB Layout



- A. All dimensions are in millimeters.
- B. For more information, see FemtoFET Surface Mount Guide (SLRA003D).

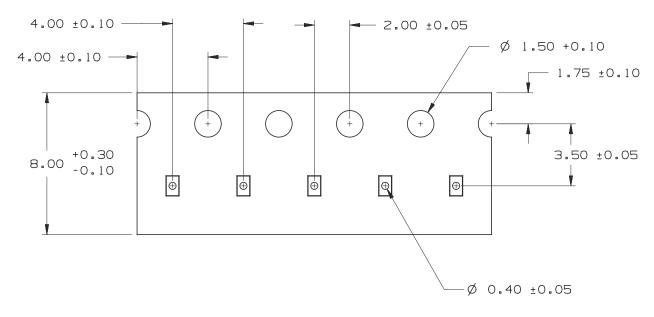
7.3 Recommended Stencil Pattern

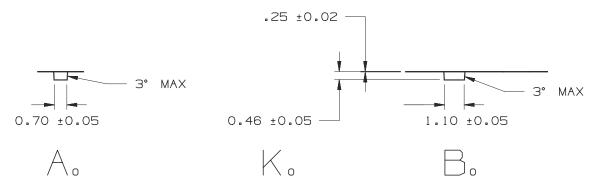


A. All dimensions are in millimeters.



7.4 CSD13381F4 Embossed Carrier Tape Dimensions





A. Pin 1 is oriented in the top-right quadrant of the tape enclosure (quadrant 2), closest to the carrier tape sprocket holes.

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
	(-)	(-)			(-)	(4)	(5)		(-)
CSD13381F4	Active	Production	PICOSTAR (YJC) 3	3000 LARGE T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	DQ
CSD13381F4.B	Active	Production	PICOSTAR (YJC) 3	3000 LARGE T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	DQ
CSD13381F4T	Active	Production	PICOSTAR (YJC) 3	250 SMALL T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	DQ
CSD13381F4T.B	Active	Production	PICOSTAR (YJC) 3	250 SMALL T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	DQ

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION



TAPE DIMENSIONS KO P1 BO W Cavity A0

A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD13381F4	ICOSTAF	YJC	3	3000	180.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2
CSD13381F4T	ICOSTAF	YJC	3	250	180.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2

PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD13381F4	PICOSTAR	YJC	3	3000	182.0	182.0	20.0
CSD13381F4T	PICOSTAR	YJC	3	250	182.0	182.0	20.0

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